

Vishay Semiconductors

"Half Bridge" IGBT MTP (Ultrafast NPT IGBT), 80 A

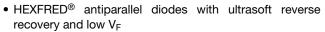


MTP

PRIMARY CHARACTERISTICS					
V_{CES}	1200 V				
$V_{CE(on)}$ typical at $V_{GE} = 15 \text{ V}$	3.36 V				
I_C at $T_C = 25$ °C	80 A				
Speed	8 kHz to 30 kHz				
Package	MTP				
Circuit configuration	Half bridge				

FEATURES

- Ultrafast non punch through (NPT) technology
- Positive V_{CE(on)} temperature coefficient
- 10 µs short circuit capability
- Square RBSOA



- Al₂O₃ DBC
- Very low stray inductance design for high speed operation
- UL approved file E78996
- · Designed and qualified for industrial level
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

Note

This datasheet provides information about parts that are RoHS-compliant and / or parts that are non RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details

BENEFITS

- Optimized for welding, UPS and SMPS applications
- Rugged with ultrafast performance
- Benchmark efficiency above 20 kHz
- Outstanding ZVS and hard switching operation
- · Low EMI, requires less snubbing
- Excellent current sharing in parallel operation
- Direct mounting to heatsink
- PCB solderable terminals
- · Very low junction to case thermal resistance

ABSOLUTE MAXIMUM RATINGS					
PARAMETER	SYMBOL	TEST CONDITIONS	MAX.	UNITS	
Collector to emitter breakdown voltage	V _{CES}		1200	V	
Continuous collector current		T _C = 25 °C	80		
Continuous collector current	I _C	T _C = 104 °C	40		
Pulsed collector current	I _{CM}		160	1	
Clamped inductive load current	I _{LM}		160	- A	
Diode continuous forward current	I _F	T _C = 105 °C	21		
Diode maximum forward current	I _{FM}		160		
Gate to emitter voltage	V _{GE}		± 20	V	
RMS isolation voltage	V _{ISOL}	Any terminal to case, t = 1 min	2500		
Maximum power dissipation (only IGBT)	В	T _C = 25 °C	463	W	
	P_{D}	T _C = 100 °C	185] vv	



ELECTRICAL SPECIFICATIONS (T _J = 25 °C unless otherwise specified)						
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS
Collector to emitter breakdown voltage	V _{(BR)CES}	V _{GE} = 0 V, I _C = 250 μA	1200	-	-	V
Temperature coefficient of breakdown voltage	$\Delta V_{(BR)CES}/\Delta T_J$	V _{GE} = 0 V, I _C = 3 mA (25 °C to 125 °C)	-	+1.1	-	V/°C
Collector to emitter saturation voltage V _{CE(on)}		$V_{GE} = 15 \text{ V}, I_{C} = 40 \text{ A}$	-	3.36	3.59	
	V _{CE(on)}	V _{GE} = 15 V, I _C = 80 A	-	4.53	4.91	V
		V _{GE} = 15 V, I _C = 40 A, T _J = 150 °C	=.	3.88	4.10	
		V _{GE} = 15 V, I _C = 80 A, T _J = 150 °C	-	5.35	5.68	
Gate threshold voltage	V _{GE(th)}	$V_{CE} = V_{GE}, I_{C} = 500 \mu A$	4	-	6	
Temperature coefficient of threshold voltage	$V_{GE(th)}/\Delta T_J$	V _{CE} = V _{GE} , I _C = 1 mA (25 °C to 125 °C)	-	-12	-	mV/°C
Transconductance	9 _{fe}	$V_{CE} = 50 \text{ V}, I_{C} = 40 \text{ A}, PW = 80 \mu \text{s}$	-	35	-	S
Zero gate voltage collector current I _{CES}		V _{GE} = 0 V, V _{CE} = 1200 V, T _J = 25 °C	-	-	250	μΑ
	I _{CES}	V _{GE} = 0 V, V _{CE} = 1200 V, T _J = 125 °C	-	0.4	1.0	mA
		V _{GE} = 0 V, V _{CE} = 1200 V, T _J = 150 °C	-	0.2	10	I IIIA
Gate to emitter leakage current	I _{GES}	V _{GE} = ± 20 V	-	-	± 250	nA

SWITCHING CHARACTERISTICS (T _J = 25 °C unless otherwise specified)						
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS
Total gate charge (turn-on)	Qg	I _C = 40 A	-	399	599	
Gate to emitter charge (turn-on)	Q_{ge}	V _{CC} = 600 V	-	43	65	nC
Gate to collector charge (turn-on)	Q _{gc}	V _{GE} = 15 V	-	187	281	
Turn-on switching loss	E _{on}	$V_{CC} = 600 \text{ V}, I_{C} = 40 \text{ A}, V_{GE} = 15 \text{ V},$	-	1.14	1.71	
Turn-off switching loss	E _{off}	$R_g = 5 \Omega$, L = 200 μ H, $T_J = 25 ^{\circ}$ C, energy losses include tail and diode	-	1.35	2.02	
Total switching loss	E _{tot}	reverse recovery	-	2.49	3.73	
Turn-on switching loss	E _{on}	$V_{CC} = 600 \text{ V}, I_{C} = 40 \text{ A}, V_{GE} = 15 \text{ V},$	-	1.60	2.40	mJ
Turn-off switching loss	E _{off}	$R_g = 5 \Omega$, L = 200 μH, T_J = 125 °C, energy losses include tail and diode reverse recovery	-	1.62	2.43	
Total switching loss	E _{tot}		-	3.22	4.82	
Input capacitance	C _{ies}	V _{GE} = 0 V V _{CC} = 30 V	-	5521	8282	
Output capacitance	C _{oes}		-	380	570	pF
Reverse transfer capacitance	C _{res}	f = 1.0 MHz	-	171	257	
Reverse bias safe operating area	RBSOA	$\begin{split} T_J &= 150 \text{ °C, } I_C = 160 \text{ A} \\ V_{CC} &= 1000 \text{ V, } V_p = 1200 \text{ V} \\ R_g &= 5 \Omega, V_{GE} = + 15 \text{ V to 0 V} \end{split}$	Fullsquare			
Short circuit safe operating area	SCSOA	$T_J = 150 ^{\circ}\text{C},$ $V_{CC} = 900 \text{V}, V_p = 1200 \text{V}$ $R_g = 5 \Omega, V_{GE} = +15 \text{V} \text{to 0 V}$	10	-	-	μs

DIODE SPECIFICATIONS (T _J = 25 °C unless otherwise specified)						
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS
		I _C = 40 A	-	2.98	3.38	
Diode forward voltage drop V _{FM}	I _C = 80 A	-	3.90	4.41	V	
	I _C = 40 A, T _J = 125 °C	-	3.08	3.39		
	I _C = 80 A, T _J = 125 °C	-	4.29	4.72		
	I _C = 40 A, T _J = 150 °C	-	3.12	3.42		
Reverse recovery energy of the diode	E _{rec}	V _{GE} = 15 V, R _q = 5 Ω, L = 200 μH	-	574	861	μJ
Diode reverse recovery time	t _{rr}	$V_{CC} = 600 \text{ V}, I_{C} = 40 \text{ A}$		120	180	ns
Peak reverse recovery current	I _{rr}	T _J = 125 °C	-	43	65	Α



THERMAL AND MECHANICAL SPECIFICATIONS						
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS
Operating junction temperature range	TJ		-40	-	150	°C
Storage temperature range	T _{Stg}		-40	-	125	
Junction to case	В		-	-	0.29	
Diode	- R _{thJC}		-	-	0.61	°C/W
Case to sink per module	R _{thCS}	Heatsink compound thermal conductivity = 1 W/mK	-	0.06	-	
Clearance (1)		External shortest distance in air between 2 terminals	5.5	-	-	
Creepage (2)		Shortest distance along external surface of the insulating material between 2 terminals	8	-	-	mm
Mounting torque to heatsink		A mounting compound is recommended and the torque should be checked after 3 hours to allow for the spread of the compound. Lubricated threads.	r 3 ± 10 %		Nm	
Weight				66		g

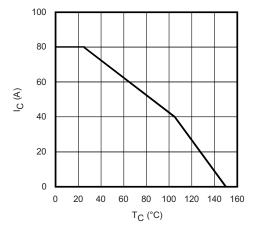


Fig. 1 - Maximum DC Collector Current vs. Case Temperature

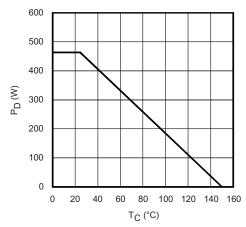


Fig. 2 - Power Dissipation vs. Case Temperature

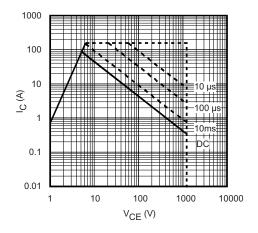


Fig. 3 - Forward SOA $T_C = 25$ °C; $T_J \le 150$ °C

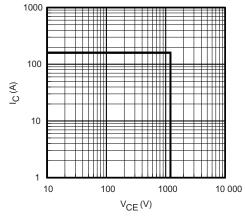


Fig. 4 - Reverse BIAS SOA $T_J = 150$ °C; $V_{GE} = 15$ V

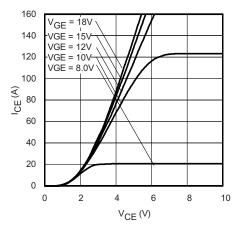


Fig. 5 - Typical IGBT Output Characteristics $T_J =$ - 40 °C; $t_p =$ 80 μs

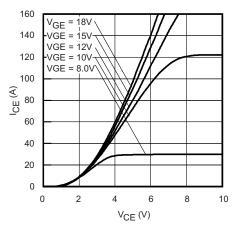


Fig. 6 - Typical IGBT Output Characteristics $T_J = 25\ ^{\circ}C;\, t_p = 80\ \mu s$

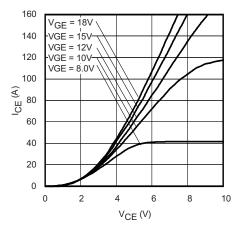


Fig. 7 - Typical IGBT Output Characteristics $T_J = 125~^{\circ}C; t_p = 80~\mu s$

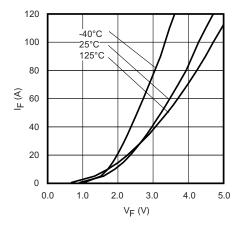


Fig. 8 - Typical Diode Forward Characteristics $t_p = 80 \; \mu s$

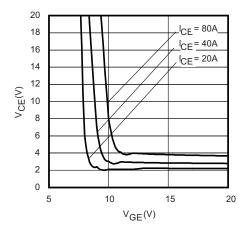


Fig. 9 - Typical V_{CE} vs. V_{GE} T_{J} = -40 °C

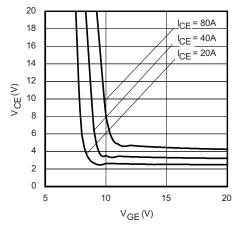


Fig. 10 - Typical V_{CE} vs. V_{GE} T_{J} = 25 °C





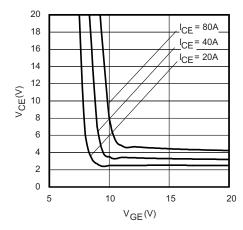


Fig. 11 - Typical V_{CE} vs. V_{GE} T_{J} = 125 °C

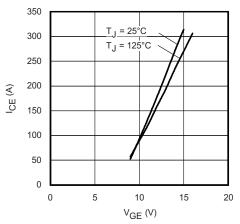


Fig. 12 - Typical Transfer Characteristics V_{CE} = 50 V; t_p = 10 μs

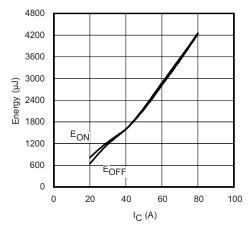


Fig. 13 - Typical Energy Loss vs. I_C T_J = 125 °C; L = 250 μ H; V_{CE} = 400 V R_g = 5 Ω ; V_{GE} = 15 V

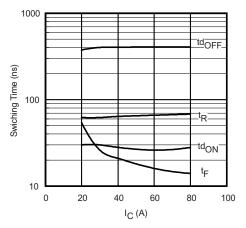


Fig. 14 - Typical Switching Time vs. I_C T_J = 125 °C; L = 250 μ H; V_{CE} = 400 V R_g = 5 Ω ; V_{GE} = 15 V

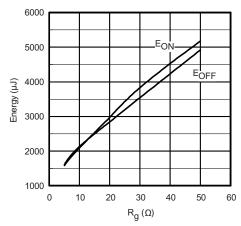


Fig. 15 - Typical Energy Loss vs. R_g T_J = 150 °C; L = 250 μ H; V_{CE} = 600 V I_{CE} = 40 A; V_{GE} = 15 V

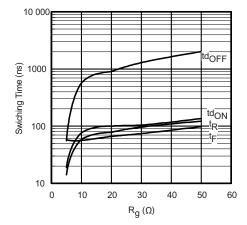


Fig. 16 - Typical Switching Time vs. R_g $T_J = 150$ °C; $L = 250~\mu H$; $V_{CE} = 600~V$ $I_{CE} = 40~A$; $V_{GE} = 15~V$





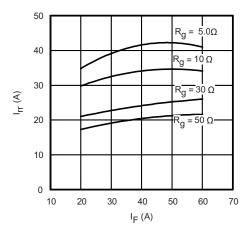


Fig. 17 - Typical Diode I_{rr} vs. I_{F} T_{J} = 125 °C

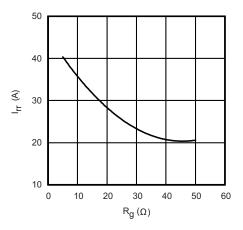


Fig. 18 - Typical Diode I_{rr} vs. R_g $T_J = 125$ °C; $I_F = 40$ A

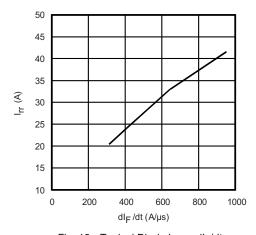


Fig. 19 - Typical Diode I $_{rr}$ vs. dI $_F$ /dt V $_{CC}$ = 600 V; V $_{GE}$ = 15 V; I $_{CE}$ = 40 A; T $_{J}$ = 125 °C

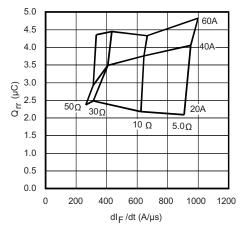


Fig. 20 - Typical Diode Q_{rr} vs. dI_F/dt V_{CC} = 600 V; V_{GE} = 15 V; T_J = 125 °C

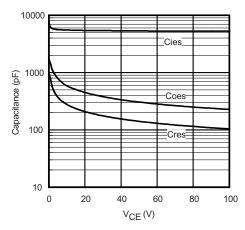


Fig. 21 - Typical Capacitance vs. V_{CE} $V_{GE} = 0 \text{ V}$; f = 1 MHz

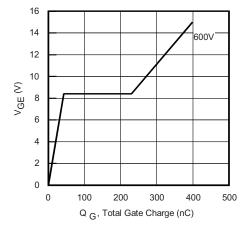


Fig. 22 - Typical Gate Charge vs. V_{GE} $I_{CE}=5.0$ A; $L=600~\mu H$

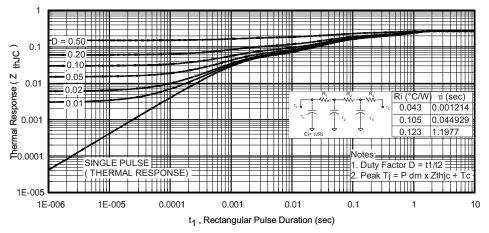


Fig. 23 - Maximum Transient Thermal Impedance, Junction to Case (IGBT)

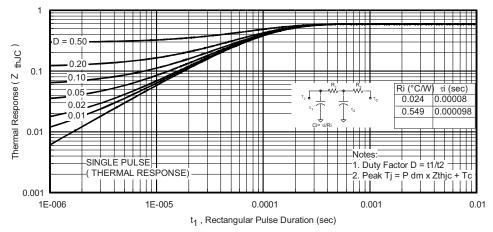


Fig. 24 - Maximum Transient Thermal Impedance, Junction to Case (Diode)

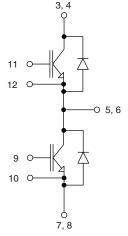
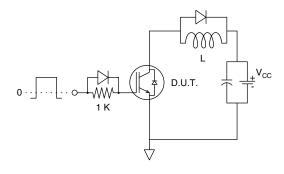


Fig. 25 - Electrical diagram



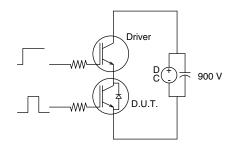


Fig. CT.1 - Gate Charge Circuit (Turn-Off)

Fig. CT.3 - S.C. SOA Circuit

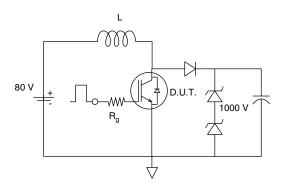


Fig. CT.2 - RBSOA Circuit

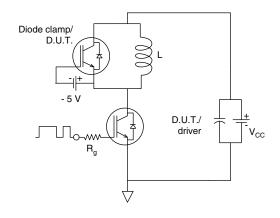
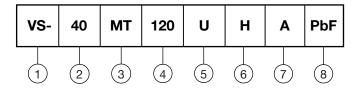


Fig. CT.4 - Switching Loss Circuit

ORDERING INFORMATION TABLE

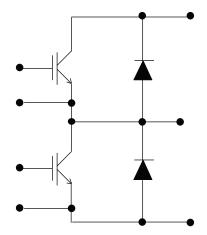
Device code



- 1 Vishay Semiconductors product
- 2 Current rating (40 = 40 A)
- Essential part number
- 4 Voltage code (120 = 1200 V)
- 5 Speed / type (U = ultrafast IGBT)
- **6** Circuit configuration (H = half bridge)
- **7** $A = Al_2O_3$ DBC substrate
- 8 PbF = lead (Pb)-free



CIRCUIT CONFIGURATION

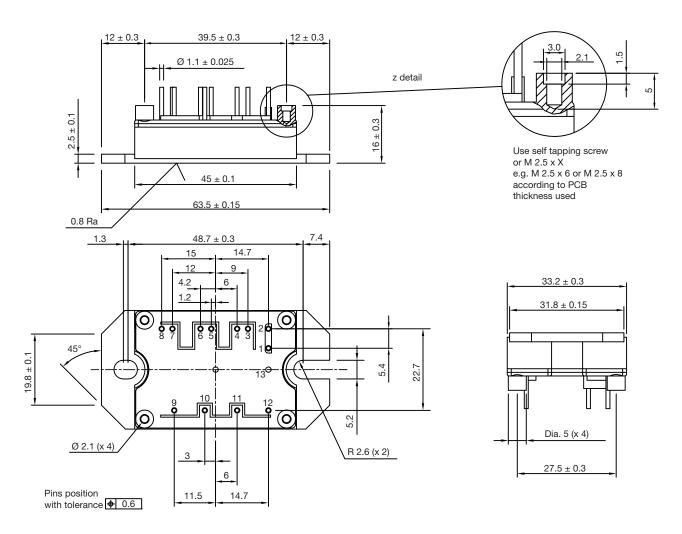


LINKS TO RELATED DOCUMENTS				
Dimensions	www.vishay.com/doc?95175			



MTP

DIMENSIONS in millimeters



Note

· Unused terminals are not assembled in the package

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